


Device Type	V_{RRM} (1)	V_{DRM} (1)	V_{RSM} (1)
KP610/12	1200	1200	1400
KP610/14	1400	1400	1600
KP610/16	1600	1600	1760
KP610/18	1800	1800	1900

V_{RRM} = Repetitive peak reverse voltage
 V_{DRM} = Repetitive peak off state voltage
 V_{RSM} = Non repetitive peak reverse voltage (2)

Repetitive peak reverse leakage and off state leakage	I_{RRM}/I_{DRM}	2 mA 25 mA (3)
Critical rate of voltage rise	dv/dt (4)	1000 V/

Peak gate power dissipation	P_{GM}		20		W	
Average gate power dissipation	$P_{G(AV)}$		4		W	
Gate-trigger current	I_{GT}		120		mA	$V_D = 12\text{ V}; R_L = 3\text{ ohms}; T_j = +25\text{ }^\circ\text{C}$
Gate- trigger voltage	V_{GT}	0.70	2.5		V	$V_D = 12\text{ V}; R_L = 3\text{ ohms}; T_j = +25\text{ }^\circ\text{C}$
Peak negative voltage	V_{GRM}		5		V	

Delay time t_d 3.0 2.5 s $I_{TM}=100\text{A}; V_D=67\%V$



